Application/Control No. Applicant(s)/Patent Under Reexamination 09/890,863 HAYAKAWA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Jenna-Leigh Befumo 1771 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-Α US-В US-С D US-US-Ε US-F G US-US-Н

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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